

**Features**

- Uses CRM(CQ) advanced Trench technology
- Extremely low on-resistance  $R_{DS(on)}$
- Excellent  $Q_g \times R_{DS(on)}$  product(FOM)
- Qualified according to JEDEC criteria

**Product Summary**

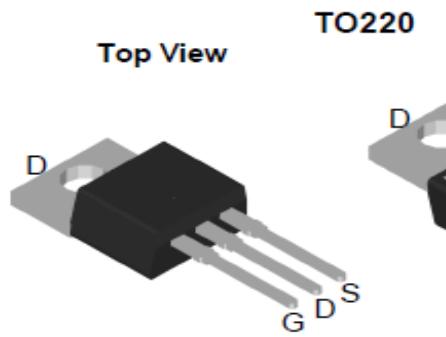
$V_{DS}$	80V
$R_{DS(on)}$ typ.	6.3mΩ
$I_D$	110A

100% DVDS Tested

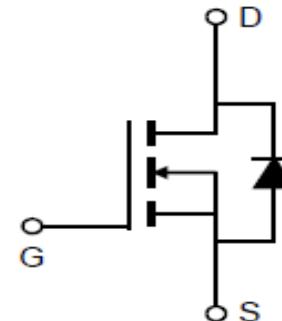
**Applications**

- Motor control and drive
- Battery management
- UPS (Uninterruptible Power Supplies)

100% Avalanche Tested



Bottom View


**Package Marking and Ordering Information**

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRTT084N08N	CRTT084N08N	TO-220	Tube	N/A	N/A	50pcs

**Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Drain-source voltage	$V_{DS}$	80	V
Continuous drain current $T_C = 25^\circ\text{C}$ (Silicon limit) $T_C = 25^\circ\text{C}$ (Package limit) $T_C = 100^\circ\text{C}$ (Silicon limit)	$I_D$	110 124 70	A
Pulsed drain current ( $T_C = 25^\circ\text{C}$ , $t_p$ limited by $T_{j,\max}$ )	$I_{D\text{ pulse}}$	440	A
Avalanche energy, single pulse ( $L=0.5\text{mH}$ , $R_g=25\Omega$ )	$E_{AS}$	169	mJ
Gate-Source voltage	$V_{GS}$	$\pm 25$	V
Power dissipation ( $T_C = 25^\circ\text{C}$ )	$P_{tot}$	172	W
Operating junction and storage temperature	$T_j, T_{stg}$	-55...+150	°C
Soldering temperature, wave soldering only allowed at leads (1.6mm from case for 10s)	$T_{sold}$	260	°C

**Thermal Resistance**

Parameter	Symbol	Max	Unit
Thermal resistance, junction - case.	R <sub>thJC</sub>	0.73	°C/W
Thermal resistance, junction - ambient(min. footprint)	R <sub>thJA</sub> *	84	

**Electrical Characteristic (at T<sub>j</sub> = 25 °C, unless otherwise specified)**

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

**Static Characteristic**

Drain-source breakdown voltage	BV <sub>DSS</sub>	80	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA
Gate threshold voltage	V <sub>GS(th)</sub>	2.4	3	3.6	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.05	1	μA	V <sub>DS</sub> =80V, V <sub>GS</sub> =0V T <sub>j</sub> =25°C T <sub>j</sub> =150°C
Gate-source leakage current	I <sub>GSS</sub>	-	±10	±100	nA	V <sub>GS</sub> =±25V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	6.3	7.8	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =40A, T <sub>j</sub> =25°C T <sub>j</sub> =150°C
Transconductance	g <sub>fs</sub>	-	41	-	S	V <sub>DS</sub> =5V, I <sub>D</sub> =40A

**Dynamic Characteristic**

Input Capacitance	C <sub>iss</sub>	-	6533	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =40V, f=1MHz
Output Capacitance	C <sub>oss</sub>	-	338	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	165	-		
Gate Total Charge	Q <sub>G</sub>	-	119	-	nC	V <sub>GS</sub> =10V, V <sub>DS</sub> =40V, I <sub>D</sub> =40A, f=1MHz
Gate-Source charge	Q <sub>gs</sub>	-	42	-		
Gate-Drain charge	Q <sub>gd</sub>	-	33	-		
Turn-on delay time	t <sub>d(on)</sub>	-	23	-	ns	V <sub>GS</sub> =10V, V <sub>DD</sub> =40V, R <sub>G_ext</sub> =2.7Ω
Rise time	t <sub>r</sub>	-	84	-		
Turn-off delay time	t <sub>d(off)</sub>	-	48	-		
Fall time	t <sub>f</sub>	-	64	-		
Gate resistance	R <sub>G</sub>	-	0.8	-	Ω	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz

**Body Diode Characteristic**

<b>Parameter</b>	<b>Symbol</b>	<b>Value</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
Body Diode Forward Voltage	V <sub>SD</sub>	-	0.9	1.4	V	V <sub>GS</sub> =0V, I <sub>SD</sub> =40A
Body Diode Forward Current	I <sub>S</sub>			110	A	T <sub>C</sub> = 25°C
Body Diode Reverse Recovery Time	t <sub>rr</sub>	-	38	-	ns	I <sub>F</sub> =40A, dI/dt=100A/μs
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	-	63	-	nC	

\*The value of R<sub>thJA</sub> is measured by placing the device in a still air box which is one cubic foot.

## Typical Performance Characteristics

Fig 1: Output Characteristics

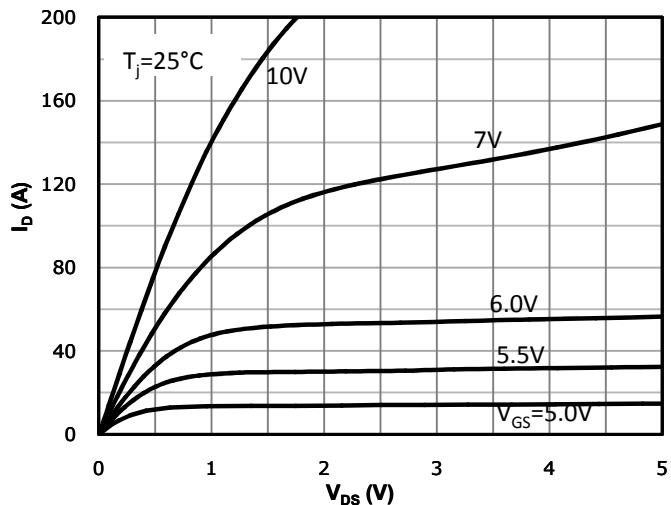


Fig 2: Transfer Characteristics

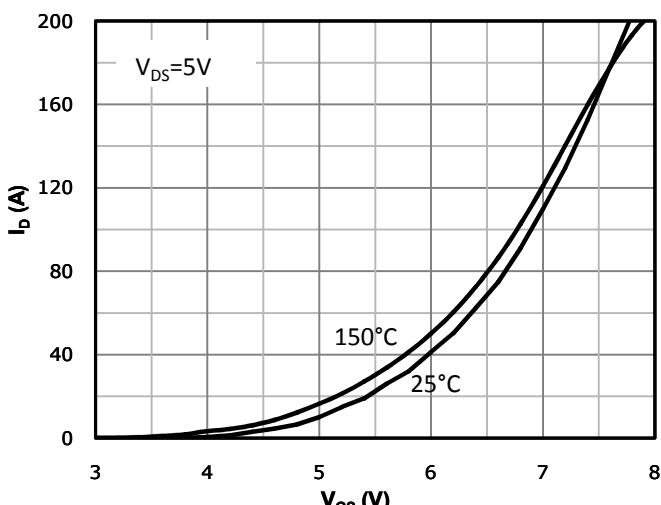
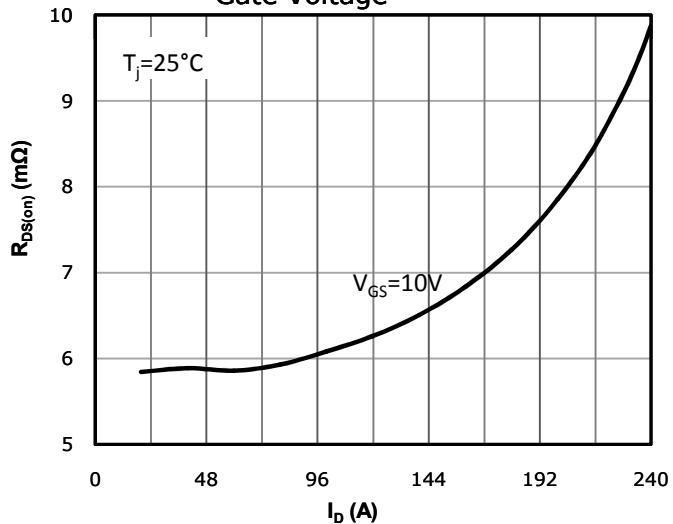
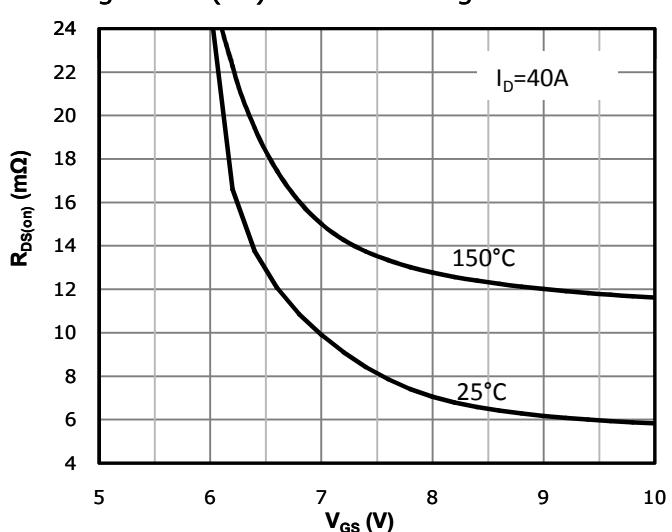
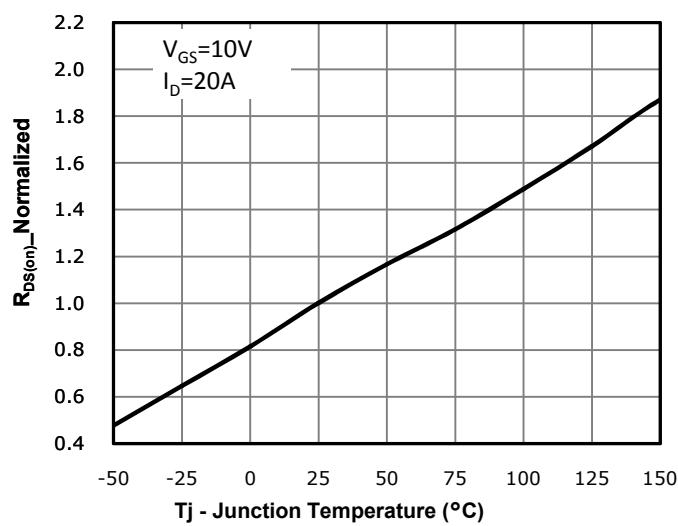

 Fig 3: R<sub>d(on)</sub> vs Drain Current and Gate Voltage

 Fig 4: R<sub>d(on)</sub> vs Gate Voltage

 Fig 5: R<sub>d(on)</sub> vs. Temperature


Fig 6: Capacitance Characteristics

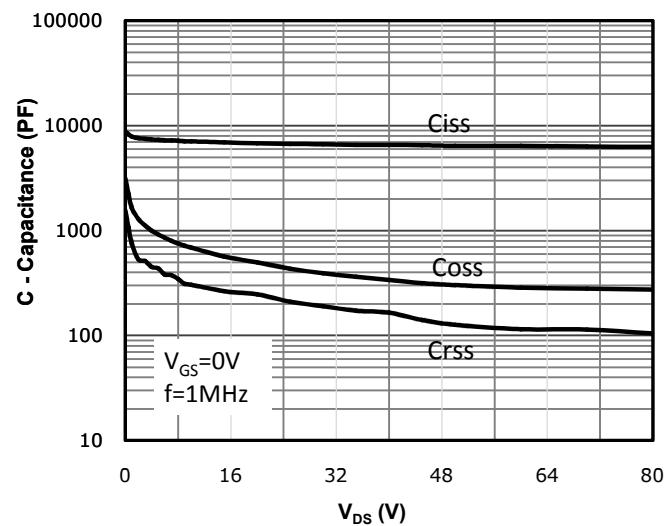


Fig 7: Gate Charge Characteristics

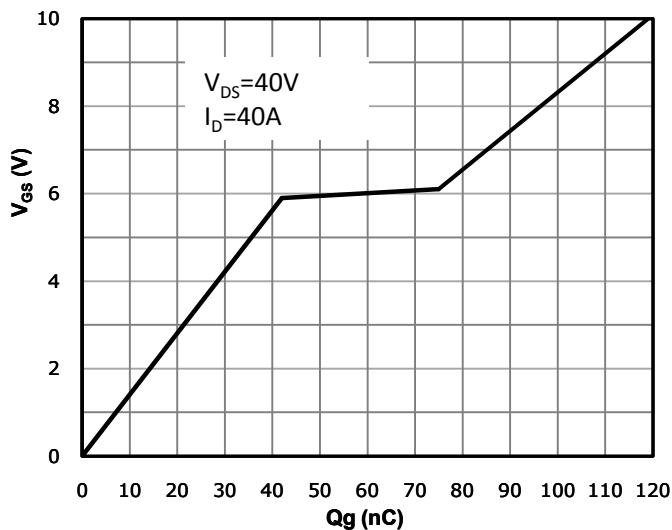


Fig 8: Body-diode Forward Characteristics

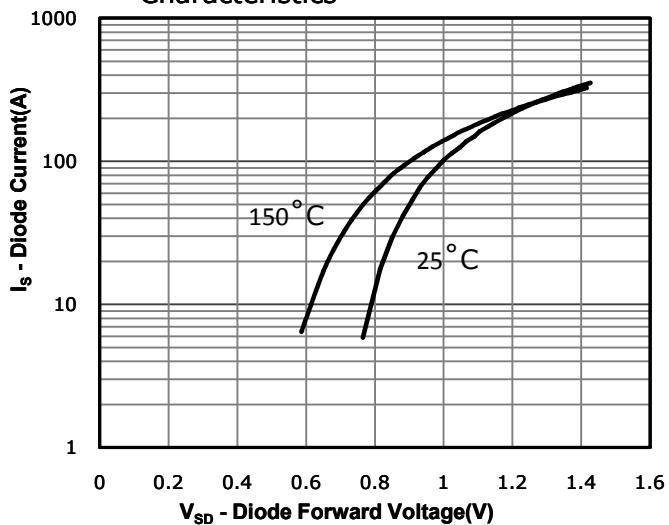


Fig 9: Power Dissipation

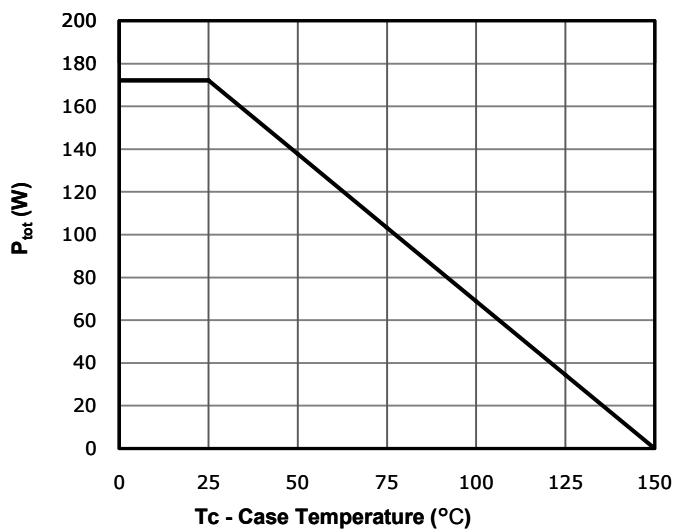


Fig 10: Drain Current Derating

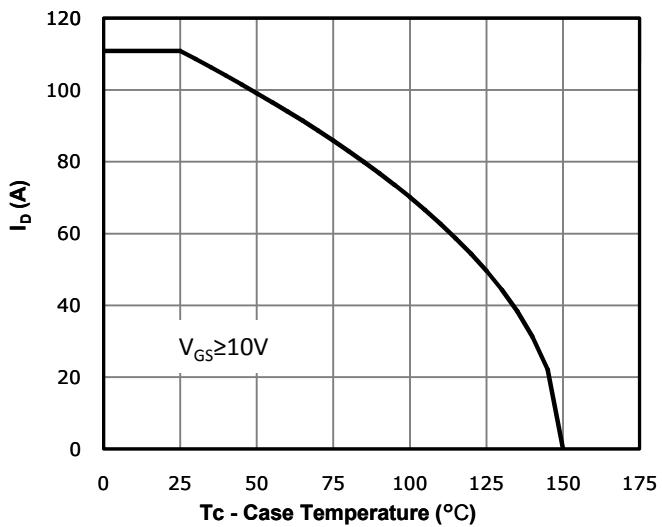


Fig 11: Safe Operating Area

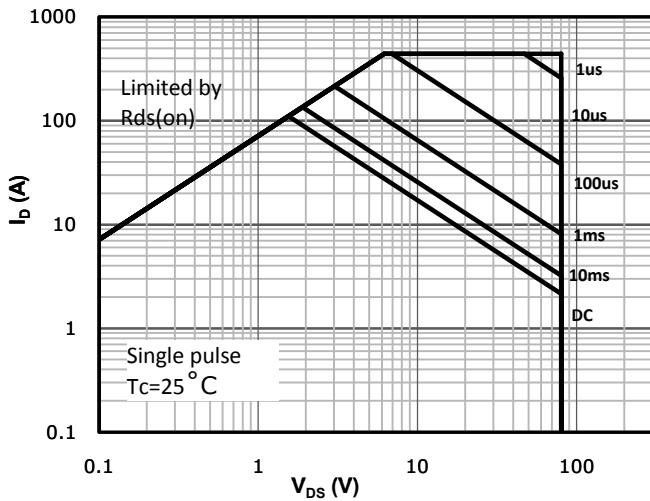
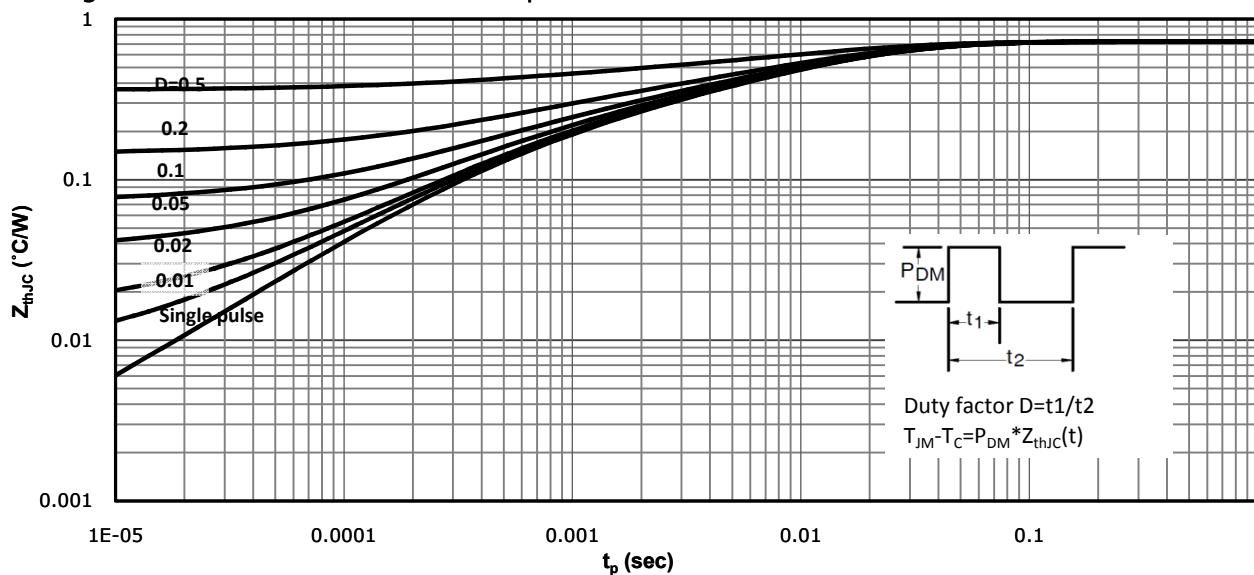
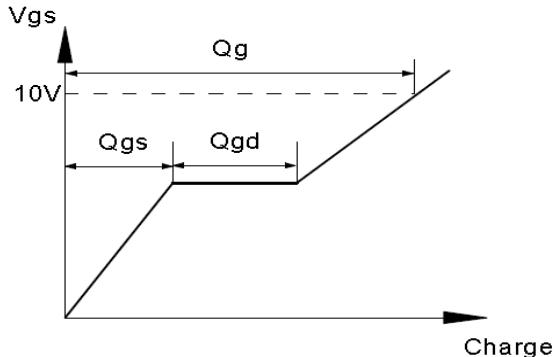
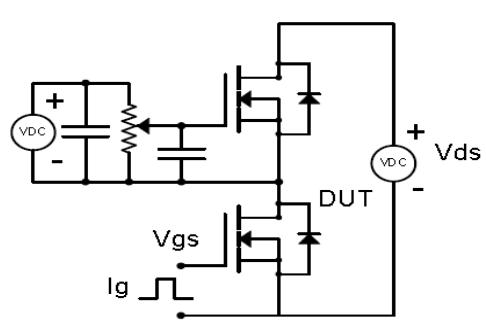


Fig 12: Max. Transient Thermal Impedance

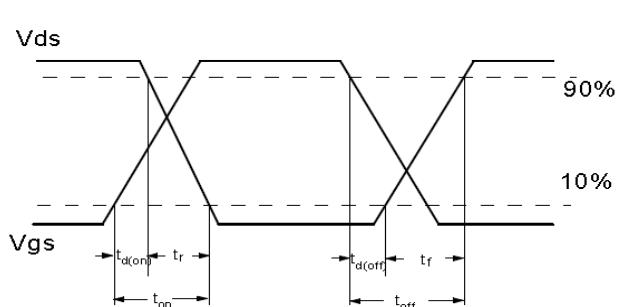
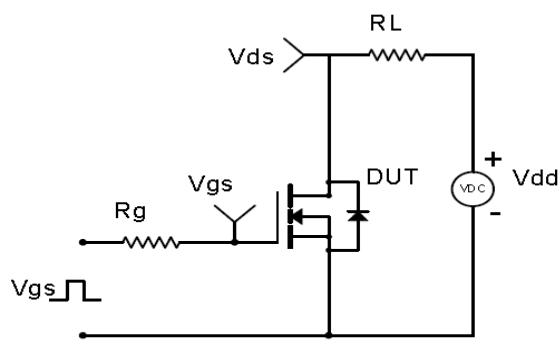


**Test Circuit & Waveform**

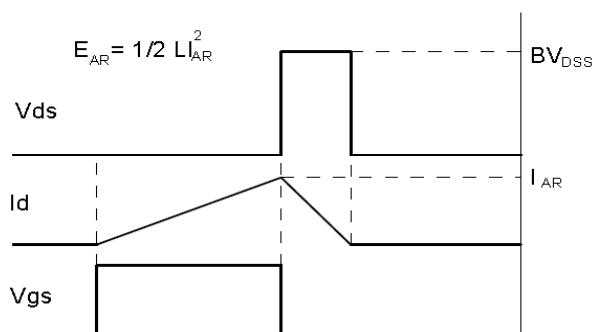
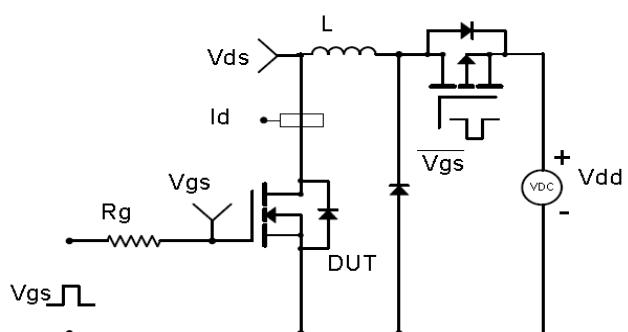
Gate Charge Test Circuit &amp; Waveform



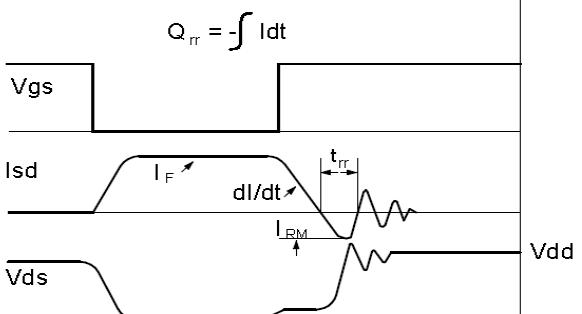
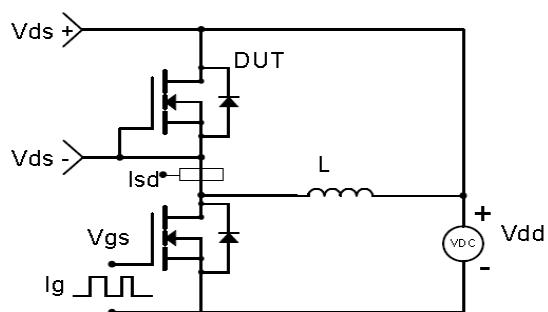
Resistive Switching Test Circuit &amp; Waveforms

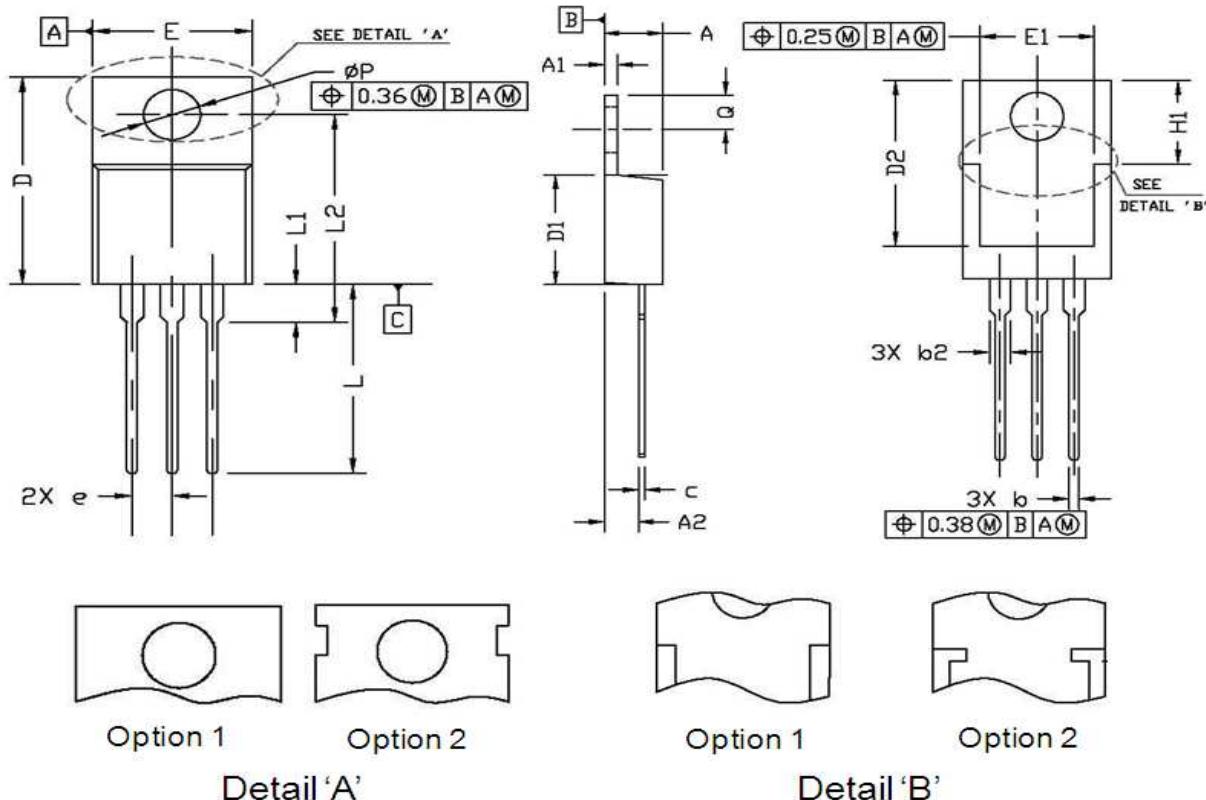


Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



Diode Recovery Test Circuit &amp; Waveforms



**Package Outline: TO-220-3L**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.30	4.80	0.169	0.189
A1	1.20	1.45	0.047	0.057
A2	2.20	2.90	0.087	0.114
b	0.69	0.95	0.027	0.037
b2	1.00	1.60	0.039	0.063
c	0.33	0.65	0.013	0.026
D	14.70	16.20	0.579	0.638
D1	8.59	9.65	0.338	0.380
D2	11.75	13.60	0.463	0.535
e	2.54 BSC.		0.100 BSC.	
E	9.60	10.60	0.378	0.417
E1	7.00	8.46	0.276	0.333
H1	6.20	7.00	0.244	0.276
L	12.60	14.80	0.496	0.583
L1	2.70	3.80	0.106	0.150
L2	12.13	16.50	0.478	0.650
Q	2.40	3.10	0.094	0.122
P	3.50	3.90	0.138	0.154

## Revision History

Revison	Date	Major changes
1.0	2018/6/11	Release of formal version
2.0	2019/5/21	Increase the environmental labeling, $I_S$ , $T_{sold}$ , $I_{DSS}$ test value at $T_j=150^\circ C$ and $I_{GSS}$ test value at $V_{GS}=-25V$ ; Update Fig2/Fig4 of Typical Performance Characteristics; Update Package Outline

## Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.